



STANDARD DESIGN

Pomona DIP Clip[®] test clips are designed for testing dual-in-line IC packages on PC boards. These devices incorporate many built-in features that assure a positive electrical connection as well as hands free testing.

- Contacts (.040" wide on lower end) are serrated for the best electrical contact.
- .025" X .028" serrated test points on upper end will accept wire wraps or mini test clips.
- Molded barriers between contacts allows live board connections without accidental shorting of contacts.
- Can also be used as an insertion tool for DIPs.
- Contacts are spring tempered Nickel Silver or Gold Plated Beryllium Copper alloy. Oxide penetrating clips have a roughened stainless steel surface treatment.
- Open back option allows probing on the chip leads while clip is attached.

Pomona's DIP Clip[®] test clips are perfect for emulation, field service, failure analysis, and for use with logic analyzers.

Model#	Size Pins	Clip Width	Type	Contact Material and Plating
5108	8	0.43in (10.9mm)	Standard DIP Clip [®]	Be-Cu, Gold Plate
5208	8	0.43in (10.9mm)	Open Back DIP Clip [®]	Be-Cu, Gold Plate
5014	14	0.72in (18.3mm)	Standard DIP Clip [®]	Nickel Silver
5114	14	0.72in (18.3mm)	Open Back DIP Clip [®]	Nickel Silver
3916A	16	0.83in (21.1mm)	Standard DIP Clip [®]	Nickel Silver
5220	20	1.03in (26.2mm)	Open Back DIP Clip [®]	Be-Cu, Gold Plate

All dimensions are in inches. Tolerances (except noted): .xx = ±.02" (.51 mm), .xxx = ±.005" (.127 mm).

All specifications are to the latest revisions. Specifications are subject to change without notice.

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